Cindy theng Haley wen



FCC PART 15 SUBPART C TEST REPORT

FCC PART 15.247

Report Reference No.....: BSL23120010P01-R01

FCC ID.....: **2BBNW-JM13**

Compiled by

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Date of issue....: December 15, 2023

Testing Laboratory Name..... **BSL Testing Co., Ltd.**

1/F, Building B, Xinshidai GR Park, Shiyan Street, Bao'an District, Address....::

Shenzhen, Guangdong, 518052, People's Republic of China

Applicant's name.....: ShenZhen XinTu Century Technology Co.,Ltd.

No. 5/FA, Building A1, Anle Industrial Zone,172 Hangcheng Address....::

Avenue, Hangcheng Street, Baoan District, Shenzhen

Test specification....::

FCC Part 15.247 Standard....:

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Test item description...... Bluetooth headset

Trade Mark....: N/A

Manufacturer..... ShenZhen XinTu Century Technology Co.,Ltd.

Model/Type reference....: JM13

Listed Models: N/A

Modulation GFSK, Π/4DQPSK, 8DPSK

Frequency..... From 2402MHz to 2480MHz

Rating...... DC 3.7V From Battery and DC 5V From External circuit

Result..... PASS



L Testing Co.,Ltd. Report No.: BSL23120010P01-R01

TEST REPORT

Equipment under Test : Bluetooth headset

Model /Type : JM13

Listed Models : N/A

Model Declaration : N/A

Applicant : ShenZhen XinTu Century Technology Co.,Ltd.

Address : No. 5/FA, Building A1, Anle Industrial Zone,172 Hangcheng

Avenue, Hangcheng Street, Baoan District, Shenzhen

Manufacturer : ShenZhen XinTu Century Technology Co.,Ltd.

Address : No. 5/FA, Building A1, Anle Industrial Zone,172 Hangcheng

Avenue, Hangcheng Street, Baoan District, Shenzhen

Test Result:	PASS

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.



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1 TEST STANDARDS

The tests were performed according to following standards:

<u>FCC Rules Part 15.247</u>: Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz. <u>ANSI C63.10-2013</u>: American National Standard for Testing Unlicensed Wireless Devices

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2 SUMMARY

2.1 General Remarks

Date of receipt of test sample	:	December 8, 2023
Testing commenced on	:	December 8, 2023
Testing concluded on	:	December 15, 2023

2.2 Product Description

Product Name:	Bluetooth headset
Model/Type reference:	JM13
Power supply:	DC 3.7V from battery or DC 5.0V from USB Port
Adapter information (Auxiliary test supplied by testing Lab)	Model: EP-TA20CBC Input: AC 100-240V 50/60Hz Output: DC 5V 2A Firmware Version: EPTA5.14.2 Manufacture: Huizhou Dongyang Yienbi Electronics Co., Ltd
Hardware version:	V1.0
Software version:	V1.0
Testing sample ID:	BSL23120010P01-R01-1# (Engineer sample) BSL23120010P01-R01-2# (Normal sample)
Bluetooth :	
Supported Type:	Bluetooth BR/EDR
Modulation:	GFSK, π/4DQPSK, 8DPSK
Operation frequency:	2402MHz~2480MHz
Channel number:	79
Channel separation:	1MHz
Antenna type:	Ceramic antenna
Antenna gain:	1.7dBi

2.3 Equipment Under Test

Power supply system utilised

Power supply voltage	:	0	230V / 50 Hz	0	120V / 60Hz
		0	12 V DC	0	24 V DC
			Other (specified in blank bel	ow)

DC 3.7V From Battery and DC 5V From external circuit

2.4 Short description of the Equipment under Test (EUT)

This is a Bluetooth headset.

For more details, refer to the user's manual of the EUT.

2.5 EUT operation mode

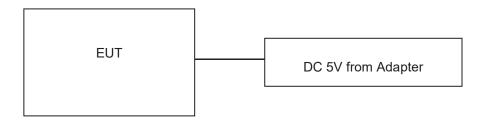
The Applicant provides communication tools software (Engineer mode) to control the EUT for staying in continuous transmitting (Duty Cycle more than 98%) and receiving mode for testing .There are 79 channels provided to the EUT and Channel 00/39/78 were selected to test.



Operation Frequency:

Channel	Frequency (MHz)
00	2402
01	2403
i i	i:
38	2440
39	2441
40	2442
i i	i i
77	2479
78	2480

2.6 Block Diagram of Test Setup



2.7 Related Submittal(s) / Grant (s)

This submittal(s) (test report) is intended for the device filing to comply with Section 15.247 of the FCC Part 15, Subpart C Rules.

2.8 Modifications

No modifications were implemented to meet testing criteria.

3 TEST ENVIRONMENT

3.1 Address of the test laboratory

BSL Testing Co., Ltd.

1/F, Building B, Xinshidai GR Park, Shiyan Street, Bao'an District, Shenzhen, Guangdong, 518052, People's Republic of China

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3.2 Test Facility

FCC-Registration No.: 562200 Designation Number: CN1338

BSL Testing Co.,Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

Industry Canada Registration Number. Is: 11093A CAB identifier: CN0019

The Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

A2LA-Lab Cert. No.: 4707.01

BSL Testing Co.,Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

3.3 Environmental conditions

During the measurement the environmental conditions were within the listed ranges: Radiated Emission:

Temperature:	24 ° C
Humidity:	45 %
Atmospheric pressure:	950-1050mbar

AC Power Conducted Emission:

Temperature:	25 ° C
Humidity:	46 %
Atmospheric pressure:	950-1050mbar

Conducted testing:

Temperature:	25 ° C
Humidity:	44 %
Atmospheric pressure:	950-1050mbar



3.4 Summary of measurement results

Test Specification clause	Test case	Test Mode	Test Channel		orded eport	Test result
§15.247(a)(1)	Carrier Frequency separation	GFSK П/4DQPSK 8DPSK		GFSK П/4DQPSK 8DPSK	⊠ Middle	Compliant
§15.247(a)(1)	Number of Hopping channels	GFSK П/4DQPSK 8DPSK	⊠ Full	GFSK	⊠ Full	Compliant
§15.247(a)(1)	Time of Occupancy (dwell time)	GFSK П/4DQPSK 8DPSK		GFSK П/4DQPSK 8DPSK	⊠ Middle	Compliant
§15.247(a)(1)	Spectrumbandwidth of aFHSS system20dB bandwidth	GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	GFSK П/4DQPSK 8DPSK		Compliant
§15.247(b)(1)	Maximum output peak power	GFSK П/4DQPSK 8DPSK	✓ Lowest✓ Middle✓ Highest	GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	Compliant
§15.247(d)	Band edgecompliance conducted	GFSK П/4DQPSK 8DPSK		GFSK П/4DQPSK 8DPSK	✓ Lowest✓ Highest	Compliant
§15.205	Band edgecompliance radiated	GFSK П/4DQPSK 8DPSK		GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Highest	Compliant
§15.247(d)	TX spuriousemissions conducted	GFSK П/4DQPSK 8DPSK		GFSK П/4DQPSK 8DPSK	以 Lowest⋈ Middle⋈ Highest	Compliant
§15.247(d)	TX spuriousemissions radiated	GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	GFSK	☑ Lowest☑ Middle☑ Highest	Compliant
§15.209(a)	TX spurious Emissions radiated Below 1GHz	GFSK П/4DQPSK 8DPSK	☑ Lowest☑ Middle☑ Highest	GFSK	⊠ Middle	Compliant
§15.107(a) §15.207	Conducted Emissions 9KHz-30 MHz	GFSK Π/4DQPSK 8DPSK		GFSK	⊠ Middle	Compliant

Remark:

- 1. The measurement uncertainty is not included in the test result.
- 2. We tested all test mode and recorded worst case in report

3.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the BSL Testing Co., Ltd.quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for BSL Testing Co., Ltd.:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	9KHz~30MHz	3.82 dB	(1)
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Transmitter power conducted	1~40GHz	0.57 dB	(1)
Conducted spurious emission	1~40GHz	1.60 dB	(1)
OBW	1~40GHz	25 Hz	(1)



(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6 Equipments Used during the Test

Conducted Emission								
Test Equipment	Manufacturer	Model	Serial No.	Date of Cal.	Due Date			
Shielding Room	ZhongYu Electron	7.3(L)x3.1(W)x2.9(H)	BSL252	2023-10-28	2024-10-27			
EMI Test Receiver	R&S	ESCI 7	BSL552	2023-10-28	2024-10-27			
Coaxial Switch	ANRITSU CORP	MP59B	BSL225	2023-10-28	2024-10-27			
ENV216 2-L-V- NETZNACHB.DE	ROHDE&SCHWARZ	ENV216	BSL226	2023-10-28	2024-10-27			
Coaxial Cable	BSL	N/A	BSL227	N/A	N/A			
EMI Test Software	AUDIX	E3	N/A	N/A	N/A			
Thermo meter	KTJ	TA328	BSL233	2023-10-28	2024-10-27			
Absorbing clamp	Elektronik- Feinmechanik	MDS21	BSL229	2023-10-28	2024-10-27			
LISN	R&S	ENV216	308	2023-10-28	2024-10-27			
LISN	R&S	ENV216	314	2023-10-28	2024-10-27			

Radiation Test equip	ment				
Test Equipment	Manufacturer	Model	Serial No.	Date of Cal.	Due Date
3m Semi- Anechoic Chamber	ZhongYu Electron	9.2(L)*6.2(W)* 6.4(H)	BSL250	2023-10-28	2024-10-27
Control Room	ZhongYu Electron	6.2(L)*2.5(W)* 2.4(H)	BSL251	N/A	N/A
EMI Test Receiver	Rohde & Schwarz	ESU26	BSL203	2023-10-28	2024-10-27
BiConiLog Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB9163	BSL214	2023-10-28	2024-10-27
Double -ridged waveguide horn	SCHWARZBECK MESS-ELEKTRONIK	BBHA 9120 D	BSL208	2023-10-28	2024-10-27
Horn Antenna	ETS-LINDGREN	3160	BSL217	2023-10-28	2024-10-27
EMI Test Software	AUDIX	E3	N/A	N/A	N/A
Coaxial Cable	BSL	N/A	BSL213	2023-10-28	2024-10-27
Coaxial Cable	BSL	N/A	BSL211	2023-10-28	2024-10-27
Coaxial cable	BSL	N/A	BSL210	2023-10-28	2024-10-27
Coaxial Cable	BSL	N/A	BSL212	2023-10-28	2024-10-27
Amplifier(100kHz- 3GHz)	HP	8347A	BSL204	2023-10-28	2024-10-27
Amplifier(2GHz- 20GHz)	HP	84722A	BSL206	2023-10-28	2024-10-27
Amplifier (18-26GHz)	Rohde & Schwarz	AFS33-18002 650-30-8P-44	BSL218	2023-10-28	2024-10-27
Band filter	Amindeon	82346	BSL219	2023-10-28	2024-10-27
Power Meter	Anritsu	ML2495A	BSL540	2023-10-28	2024-10-27
Power Sensor	Anritsu	MA2411B	BSL541	2023-10-28	2024-10-27
Wideband Radio	Rohde & Schwarz	CMW500	BSL575	2023-10-28	2024-10-27



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Communication Tester					
Splitter	Agilent	11636B	BSL237	2023-10-28	2024-10-27
Loop Antenna	ZHINAN	ZN30900A	BSL534	2023-10-28	2024-10-27
Breitband hornantenne	SCHWARZBECK	BBHA 9170	BSL579	2023-10-28	2024-10-27
Amplifier	TDK	PA-02-02	BSL574	2023-10-28	2024-10-27
Amplifier	TDK	PA-02-03	BSL576	2023-10-28	2024-10-27
PSA Series Spectrum Analyzer	Rohde & Schwarz	FSP	BSL578	2023-10-28	2024-10-27

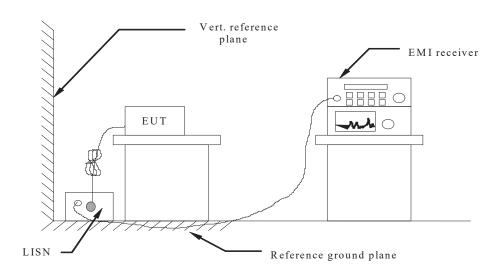
RF Conducted Test:					
Test Equipment	Manufacturer	Model	Serial No.	Date of Cal.	Due Date
MXA Signal Analyzer	Agilent	N9020A	BSL566	2023-10-28	2024-10-27
EMI Test Receiver	R&S	ESCI 7	BSL552	2023-10-28	2024-10-27
Spectrum Analyzer	Agilent	E4440A	BSL533	2023-10-28	2024-10-27
MXG vector Signal Generator	Agilent	N5182A	BSL567	2023-10-28	2024-10-27
ESG Analog Signal Generator	Agilent	E4428C	BSL568	2023-10-28	2024-10-27
USB RF Power Sensor	DARE	RPR3006W	BSL569	2023-10-28	2024-10-27
RF Switch Box	Shongyi	RFSW3003328	BSL571	2023-10-28	2024-10-27
Programmable					
Constant Temp &	WEWON	WHTH-150L-40-880	BSL572	2023-10-28	2024-10-27
Humi Test Chamber					



4 TEST CONDITIONS AND RESULTS

4.1 AC Power Conducted Emission

TEST CONFIGURATION



TEST PROCEDURE

- 1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10-2013.
- 2 Support equipment, if needed, was placed as per ANSI C63.10-2013
- 3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10-2013
- 4 The EUT received power from adapter, the adapter received AC120V/60Hz and AC 240V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- 5 All support equipments received AC power from a second LISN, if any.
- 6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.
- 8 During the above scans, the emissions were maximized by cable manipulation.

AC Power Conducted Emission Limit

For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following:

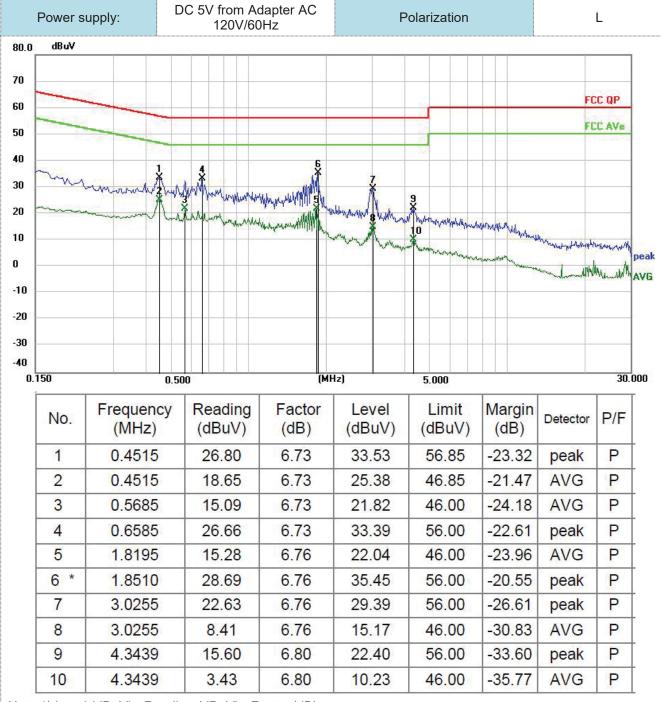
Frequency range (MHz)	Limit (dBuV)				
r requericy range (Miriz)	Quasi-peak	Average			
0.15-0.5	66 to 56*	56 to 46*			
0.5-5	56	46			
5-30	60	50			
* Decreases with the logarithm of the freque	ncy.				

TEST RESULTS

Remark:

- 1. All modes of GFSK, Π/4 DQPSK and 8-DPSK were test at Low, Middle, and High channel; only the worst result of GFSK Middle Channel was reported as below:
- 2. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:





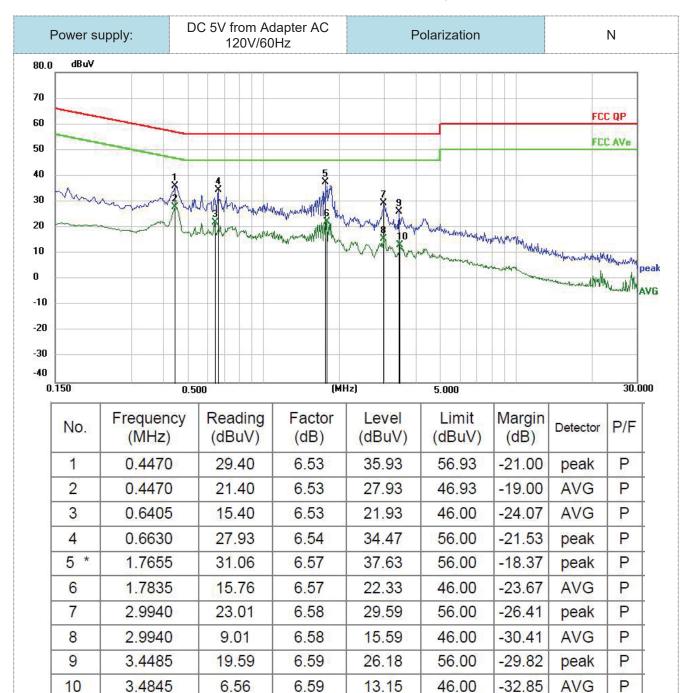
Note:1).Level (dBµV)= Reading (dBµV)+ Factor (dB)

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). Margin(dB) = Limit (dB μ V) Level (dB μ V)



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Note:1).Level (dBµV)= Reading (dBµV)+ Factor (dB)

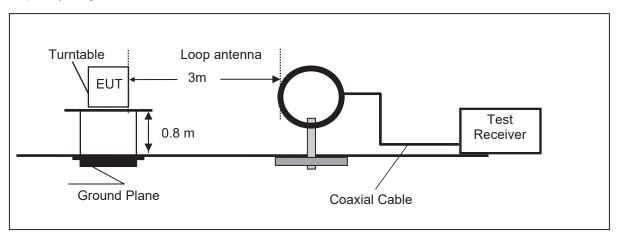
- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). Margin(dB) = Limit (dB μ V) Level (dB μ V)



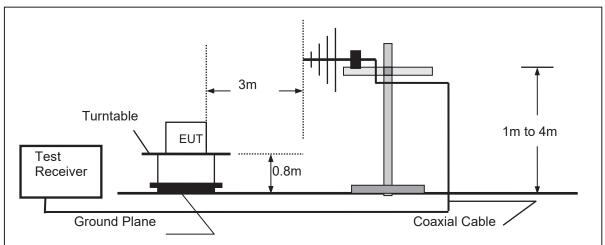
4.2 Radiated Emission

TEST CONFIGURATION

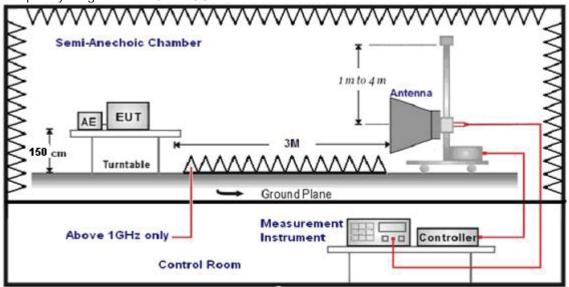
Frequency range 9KHz - 30MHz



Frequency range 30MHz - 1000MHz



Frequency range above 1GHz-25GHz





- 1. The EUT was placed on a turn table which is 0.8m above ground plane when testing frequency range 9 KHz –1GHz;the EUT was placed on a turn table which is 1.5m above ground plane when testing frequency range 1GHz 25GHz.
- 2. Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0° to 360° to acquire the highest emissions from EUT.
- 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 4. Repeat above procedures until all frequency measurements have been completed.
- 5. Radiated emission test frequency band from 9KHz to 25GHz.
- 6. The distance between test antenna and EUT as following table states:

Test Frequency range	Test Antenna Type	Test Distance
9KHz-30MHz	Active Loop Antenna	3
30MHz-1GHz	Ultra-Broadband Antenna	3
1GHz-18GHz	Double Ridged Horn Antenna	3
18GHz-25GHz	Horn Anternna	1

7. Setting test receiver/spectrum as following table states:

	·	
Test Frequency range	Test Receiver/Spectrum Setting	Detector
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP
1GHz-40GHz	Peak Value: RBW=1MHz/VBW=3MHz, Sweep time=Auto Average Value: RBW=1MHz/VBW=10Hz, Sweep time=Auto	Peak

Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

FS = RA + AF + CL - AG

Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	

Transd=AF +CL-AG

RADIATION LIMIT

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission from intentional radiators at a distance of 3 meters shall not exceed the following table. According to § 15.247(d), in any 100kHz bandwidth outside the frequency band in which the EUT is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the100kHz bandwidth within the band that contains the highest level of desired power.

The pre-test have done for the EUT in three axes and found the worst emission at position shown in test setup photos.

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)
0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)
1.705-30	3	20log(30)+ 40log(30/3)	30
30-88	3	40.0	100
88-216	3	43.5	150
216-960	3	46.0	200
Above 960	3	54.0	500



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TEST RESULTS

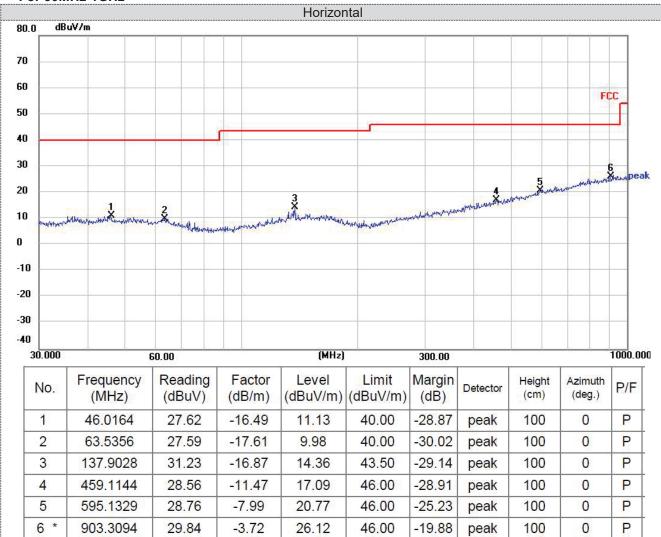
Remark:

- 1. This test was performed with EUT in X, Y, Z position and the worse case was found when EUT in X position.
- 2. We measured Radiated Emission at GFSK, $\pi/4$ DQPSK and 8-DPSK mode from 9 KHz to 25GHz and recorded worst case at GFSK DH5 mode.

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- 3. For below 1GHz testing recorded worst at GFSK DH5 middle channel.
- 4. Radiated emission test from 9 KHz to 10th harmonic of fundamental was verified, and no emission found except system noise floor in 9 KHz to 30MHz and not recorded in this report.

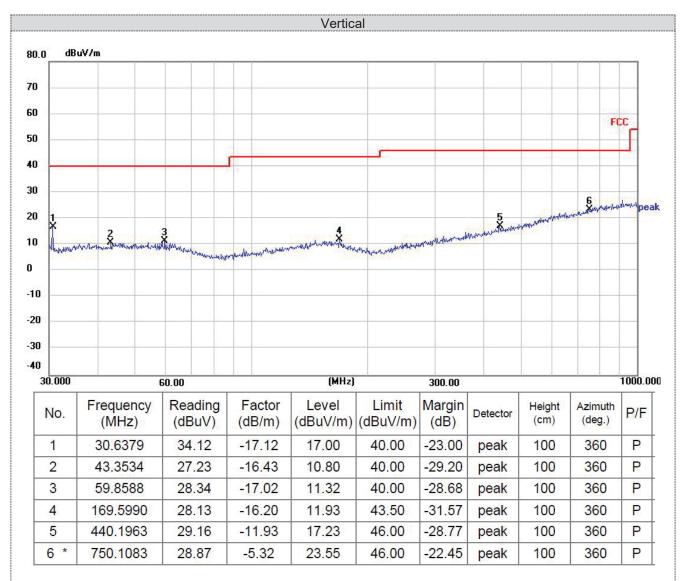
For 30MHz-1GHz



Note:1).Level ($dB\mu V/m$)= Reading ($dB\mu V/m$)+ Factor (dB/m)

- 2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) Pre Amplifier gain (dB)
- 3). Margin(dB) = Limit (dB μ V/m) Level (dB μ V/m)





Note:1).Level (dB μ V/m)= Reading (dB μ V/m)+ Factor (dB/m)

- 2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) Pre Amplifier gain (dB)
- 3). Margin(dB) = Limit (dB μ V/m) Level (dB μ V/m)

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For 1GHz to 25GHz

Note: GFSK, π/4 DQPSK and 8-DPSK all have been tested, only worse case GFSK is reported.

GFSK (above 1GHz)

1										
Freque	ncy(MHz):	24	02	Pola	arity:	y: HORIZONTAL			
Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4804.00	56.18	PK	74	17.82	60.54	32.40	5.11	41.87	-4.36	
4804.00	46.51	AV	54	7.49	50.87	32.40	5.11	41.87	-4.36	
7206.00	54.79	PK	74	19.21	55.42	36.58	6.43	43.64	-0.63	
7206.00	44.56	AV	54	9.44	45.19	36.58	6.43	43.64	-0.63	

Freque	ncy(MHz)):	24	02	Pola	arity:	VERTICAL		
Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4804.00	57.11	PK	74	16.89	61.47	32.40	5.11	41.87	-4.36
4804.00	46.88	AV	54	7.12	51.24	32.40	5.11	41.87	-4.36
7206.00	55.23	PK	74	18.77	55.86	36.58	6.43	43.64	-0.63
7206.00	45.03	AV	54	8.97	45.66	36.58	6.43	43.64	-0.63

Freque	Frequency(MHz):			2441		Polarity:		HORIZONTAL	
Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4882.00	57.59	PK	74	16.41	61.54	32.56	5.34	41.85	-3.95
4882.00	47.29	AV	54	6.71	51.24	32.56	5.34	41.85	-3.95
7323.00	55.50	PK	74	18.50	55.86	36.54	6.81	43.71	-0.36
7323.00	45.27	AV	54	8.73	45.63	36.54	6.81	43.71	-0.36

Freque	ency(MHz):		24	2441		arity: VERTICAL		Polarity: VERTI		
Frequency (MHz)		ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
4882.00	56.90	PK	74	17.10	60.85	32.56	5.34	41.85	-3.95	
4882.00	46.81	AV	54	7.19	50.76	32.56	5.34	41.85	-3.95	
7323.00	55.28	PK	74	18.72	55.64	36.54	6.81	43.71	-0.36	
7323.00	45.59	AV	54	8.41	45.95	36.54	6.81	43.71	-0.36	

Freque	ncy(MHz)	:	2480		Polarity:		HORIZONTAL		\L
Frequency (MHz)		ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	58.02	PK	74	15.98	61.48	32.73	5.64	41.83	-3.46
4960.00	47.78	AV	54	6.22	51.24	32.73	5.64	41.83	-3.46
7440.00	55.59	PK	74	18.41	55.65	36.50	7.23	43.79	-0.06
7440.00	45.52	PK	54	8.48	45.58	36.50	7.23	43.79	-0.06

Freque	Frequency(MHz):			2480		Polarity:		VERTICAL	
Frequency (MHz)	Le	ssion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	57.78	PK	74	16.22	61.24	32.73	5.64	41.83	-3.46
4960.00	47.66	AV	54	6.34	51.12	32.73	5.64	41.83	-3.46
7440.00	55.79	PK	74	18.21	55.85	36.50	7.23	43.79	-0.06
7440.00	45.59	PK	54	8.41	45.65	36.50	7.23	43.79	-0.06



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REMARKS:

- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

Results of Band Edges Test (Radiated)

Note: GFSK, Pi/4 DQPSK and 8-DPSK all have been tested, only worse case GFSK is reported. **GFSK**

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Freque	ncy(MHz)):	24	02	Pola	rity:	HORIZONTAL		\L
Frequency (MHz)	Emis Le (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2390.00	50.06	PK	74	23.94	60.48	27.42	4.31	42.15	-10.42
2390.00	48.33	AV	54	5.67	58.75	27.42	4.31	42.15	-10.42
Freque	ncy(MHz)):	24	02	Pola	rity:	VERTICAL		
Frequency (MHz)	Emis Le (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2390.00	46.22	PK	74	27.78	56.64	27.42	4.31	42.15	-10.42
2390.00	43.82	AV	54	10.18	54.24	27.42	4.31	42.15	-10.42
Freque	ncy(MHz)):	24	80	Pola	rity:	HORIZONTAL		L
Frequency (MHz)	Emis Le (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2483.50	42.13	PK	74	31.87	52.24	27.70	4.47	42.28	-10.11
2483.50	40.04	AV	54	13.96	50.15	27.70	4.47	42.28	-10.11
Freque	ncy(MHz)):	24	80	Pola	rity:	VERTICAL		
Frequency (MHz)	Emis Le (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
2483.50	38.23	PK	74	35.77	48.34	27.70	4.47	42.28	-10.11
2483.50	36.58	AV	54	17.42	46.69	27.70	4.47	42.28	-10.11

REMARKS:

- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

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4.3 Maximum Peak Output Power

Limit

The Maximum Peak Output Power Measurement is 30dBm(for GFSK)/20.97dBm(for EDR)

Test Procedure

- 1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.
- 2. Set the spectrum analyzer: RBW = 3MHz. VBW = 8MHz. Sweep = auto; Detector Function = Peak.
- 3. Keep the EUT in transmitting at lowest, medium and highest channel individually. Record the max value.

Test Configuration



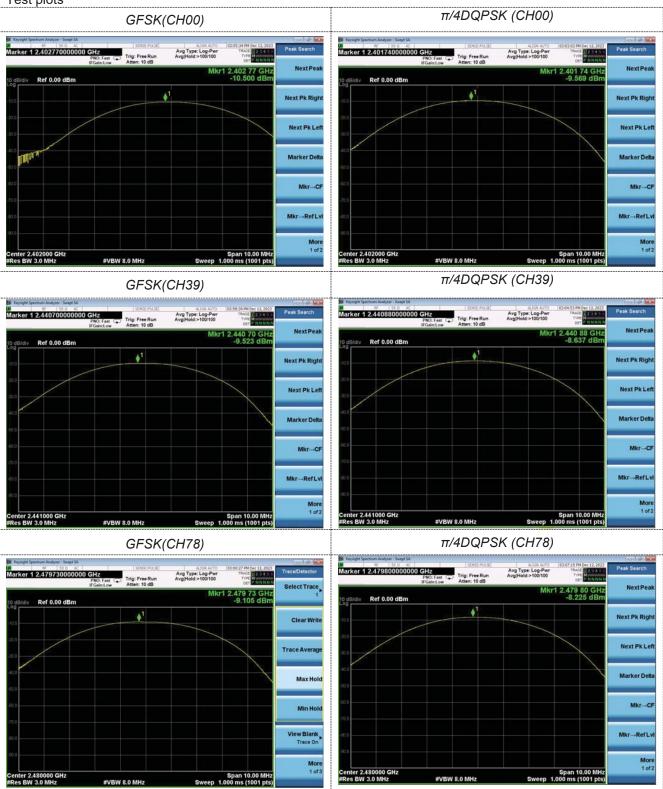
Test Results

Туре	Channel	Output power (dBm) Limit (dBm)		Result	
	00	-10.500			
GFSK	39	-9.523	30.00	Pass	
	78	-9.105			
	00	-9.569			
π/4DQPSK	39	-8.637	20.97	Pass	
	78	-8.225			
	00	-9.169			
8-DPSK	39	-8.221	20.97	Pass	
	78	-7.816			

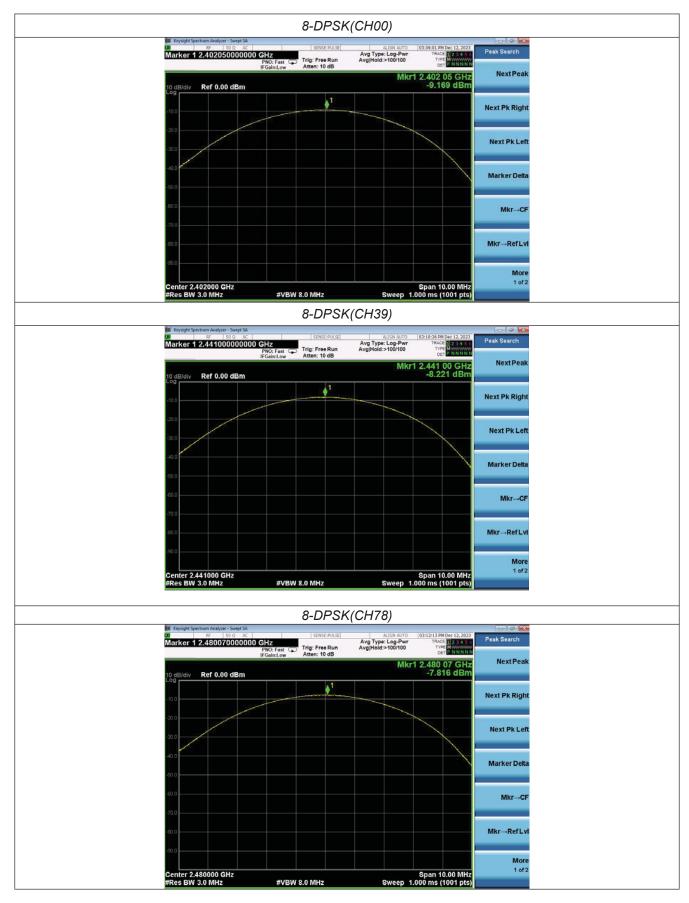
Note: 1.The test results including the cable lose.



Test plots







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4.4 20dB Bandwidth

Limit

For frequency hopping systems operating in the 2400MHz-2483.5MHz no limit for 20dB bandwidth.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 30 KHz RBW and 100 KHz VBW.

The 20dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 20dB.

Test Configuration

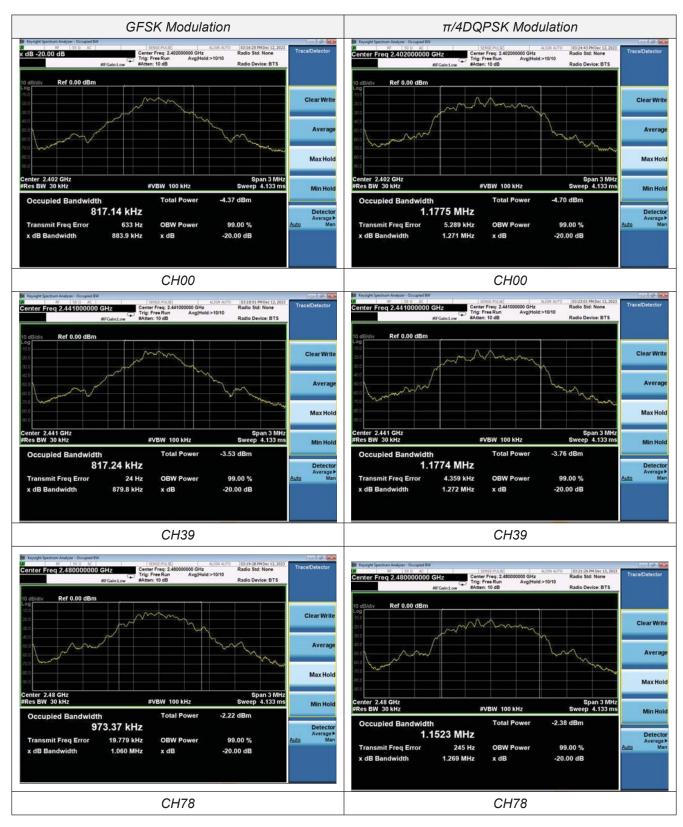


Test Results

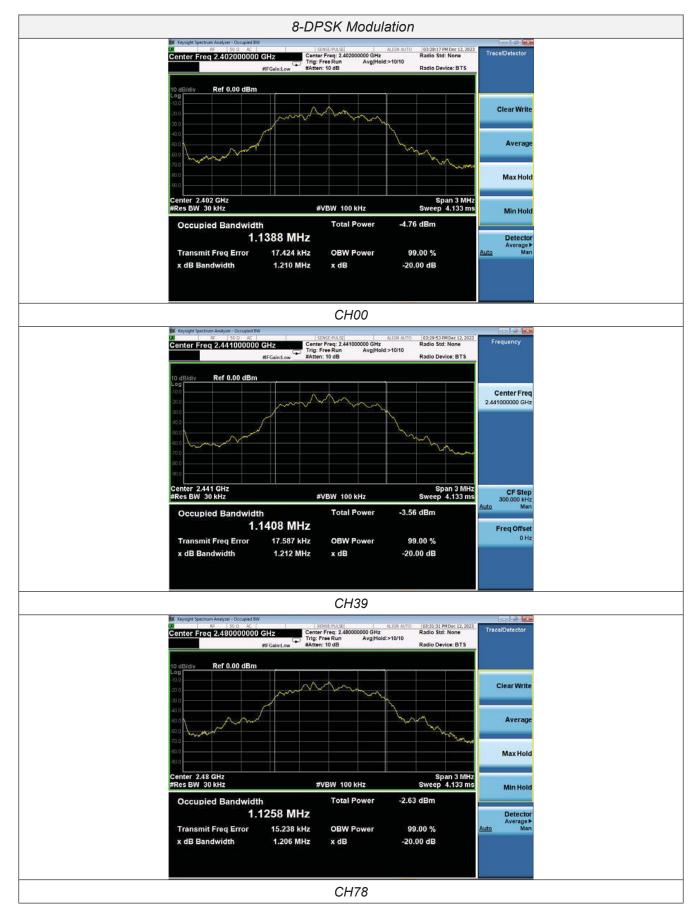
Modulation	Channel	20dB bandwidth (MHz)	Result
	CH00	0.884	
GFSK	CH39	0.880	
	CH78	1.060	
	CH00	1.271	
π/4DQPSK	CH39	1.272	Pass
	CH78	1.269	
	CH00	1.210	
8-DPSK	CH39	1.212	
	CH78	1.206	

Test plot as follows:









4.5 Frequency Separation

LIMIT

According to 15.247(a)(1), frequency hopping systems shall have hopping channel carrier frequencies separated by minimum of 25KHz or the 2/3*20dB bandwidth of the hopping channel, whichever is greater.

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TEST PROCEDURE

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 100 KHz RBW and 300 KHz VBW.

TEST CONFIGURATION



TEST RESULTS

Modulation	Channel	Channel Separation (MHz)	Limit(MHz)	Result
GFSK	CH38	1.002	0.880	Pass
Grak	CH39	1.002	0.000	Fa55
π/4DQPSK	CH38	1.022	0.848	Door
II/4DQF3K	CH39	1.022	0.040	Pass
0 DDCK	CH38	0.996	0.808	Pass
8-DPSK	CH39	0.990	0.000	Fass

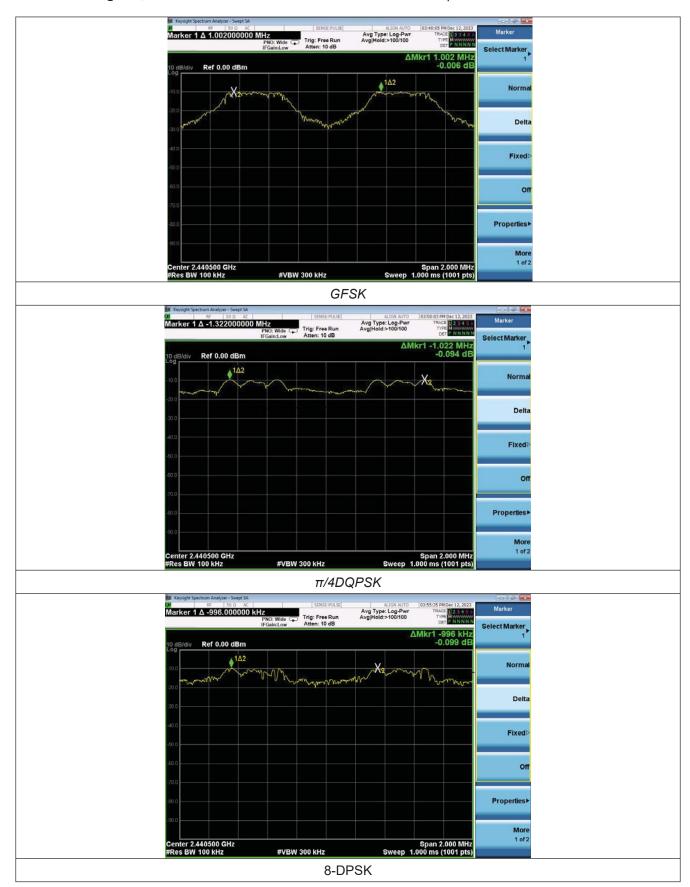
Note:

We have tested all mode at high, middle and low channel, and recorded worst case at middle

Test plot as follows:



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4.6 Number of hopping frequency

<u>Limit</u>

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. Set spectrum analyzer start 2400MHz to 2483.5MHz with 100 KHz RBW and 300 KHz VBW.

Test Configuration

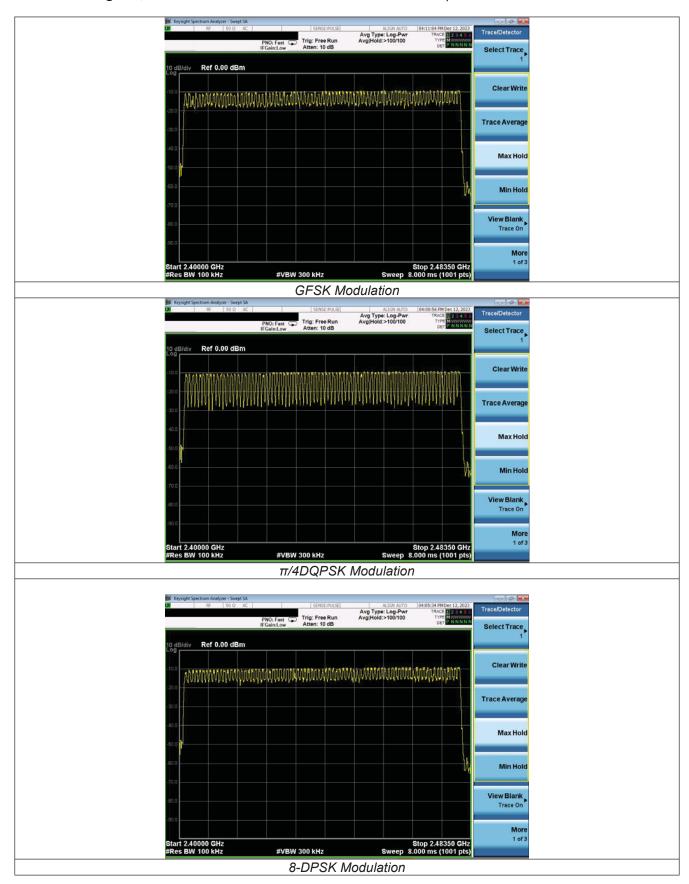


Test Results

Modulation	Number of Hopping Channel	Limit	Result
GFSK	79		
π/4DQPSK	79	≥15	Pass
8-DPSK	79		

Test plot as follows:





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4.7 Time of Occupancy (Dwell Time)

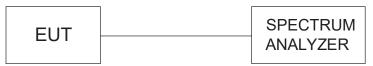
Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. Set center frequency of spectrum analyzer=operating frequency with 1MHz RBW and 3MHz VBW, Span 0Hz.

Test Configuration



Test Results

Modulation	Packet	Burst time (ms)	Dwell time (s)	Limit (s)	Result
	DH1	0.368	0.118		
GFSK	DH3	1.632	0.261	0.40	Pass
	DH5	2.888	0.308		
	2-DH1	0.368	0.118		
π/4DQPSK	2-DH3	1.632	0.261	0.40	Pass
	2-DH5	2.872	0.306		
	3-DH1	0.384	0.123		
8-DPSK	3-DH3	1.632	0.261	0.40	Pass
	3-DH5	2.872	0.306		

Note:We have tested all mode at high, middle and low channel, and recoreded worst case at middle channel.

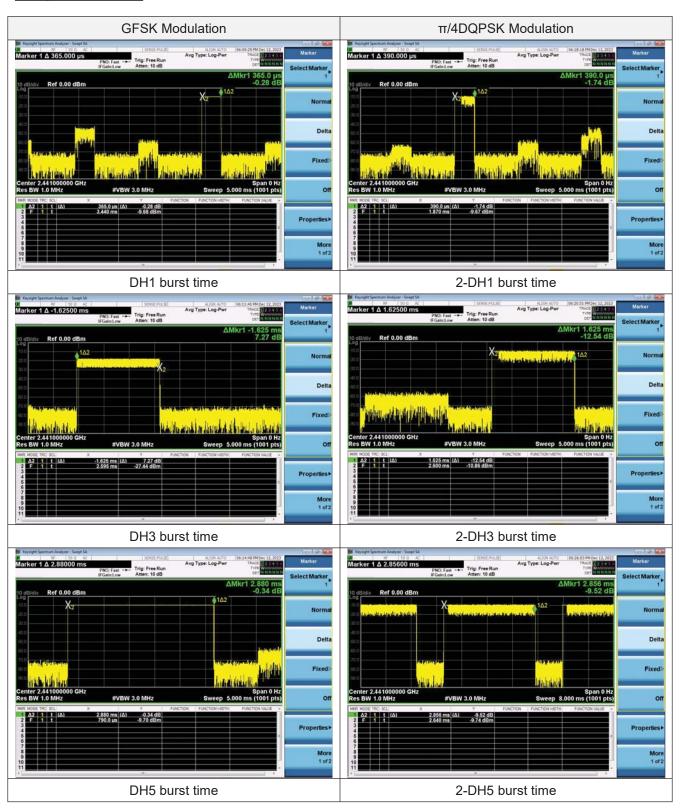
Dwell time=Pulse time (ms) × (1600 ÷ 2 ÷ 79) ×31.6 Second for DH1, 2-DH1, 3-DH1

Dwell time=Pulse time (ms) × $(1600 \div 4 \div 79)$ ×31.6 Second for DH3, 2-DH3, 3-DH2

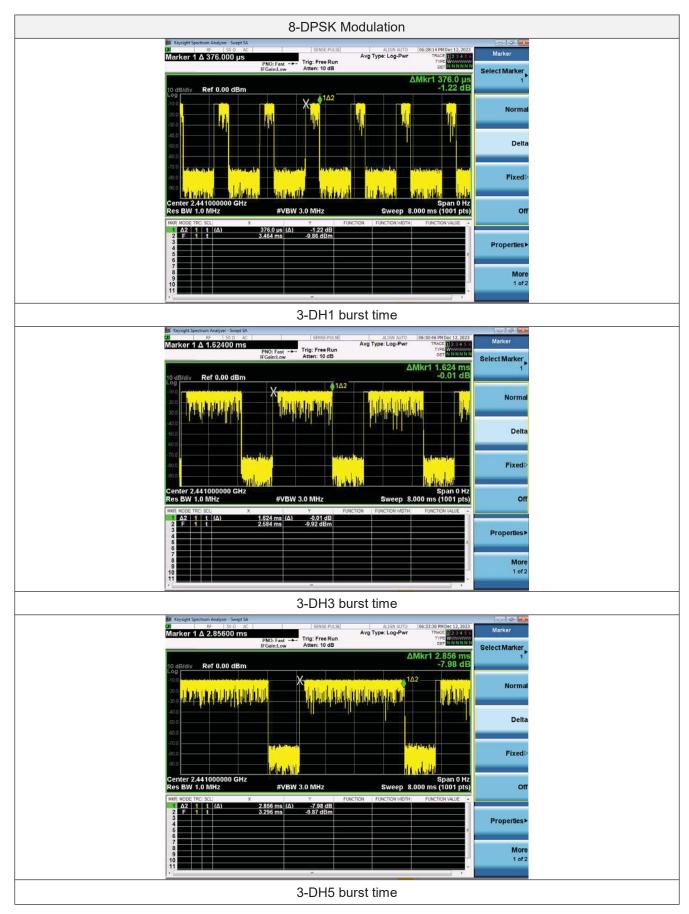
Dwell time=Pulse time (ms) × (1600 \div 6 \div 79) ×31.6 Second for DH5, 2-DH5, 3-DH3



Test plot as follows:







4.8 Out-of-band Emissions

Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF con-ducted or a radiated measurement, pro-vided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter com-plies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required.

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Test Procedure

Connect the transmitter output to spectrum analyzer using a low loss RF cable, and set the spectrum analyzer to RBW=100 kHz, VBW= 300 kHz, peak detector, and max hold. Measurements utilizing these setting are made of the in-band reference level, bandedge and out-of-band emissions.

Test Configuration



Test Results

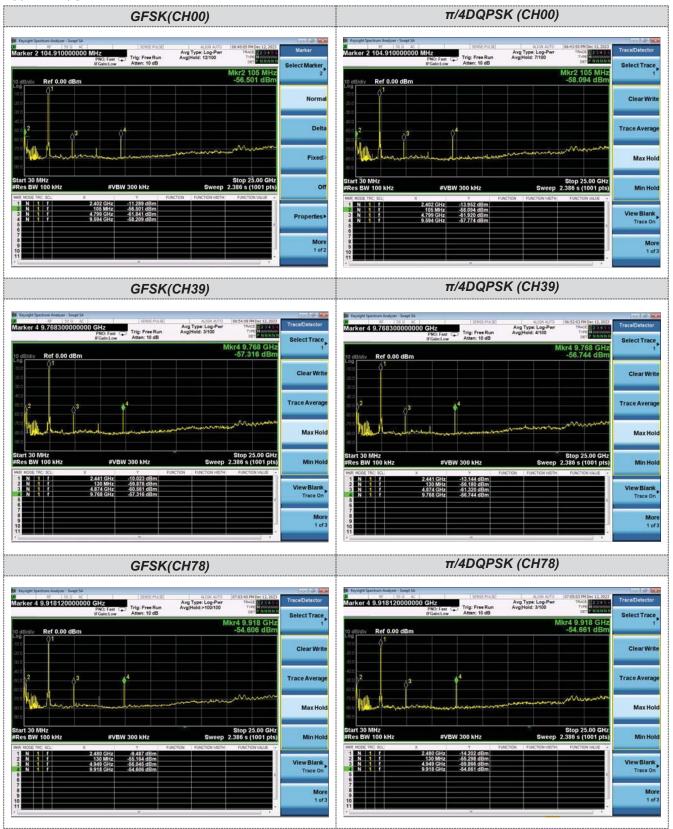
Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandage measurement data.

We measured all conditions (DH1, DH3, DH5) and recorded worst case at DH5

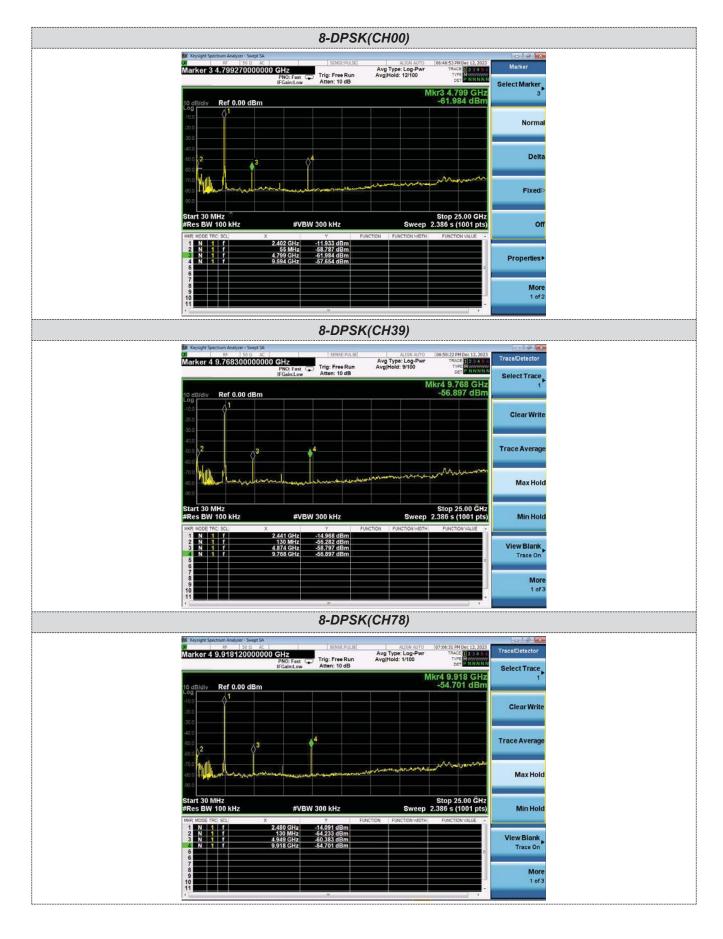
Test plot as follows:



30MHz-25G

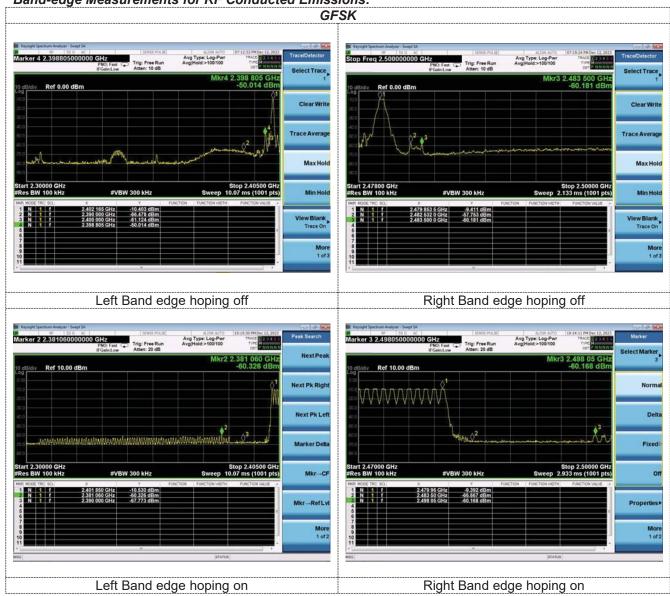




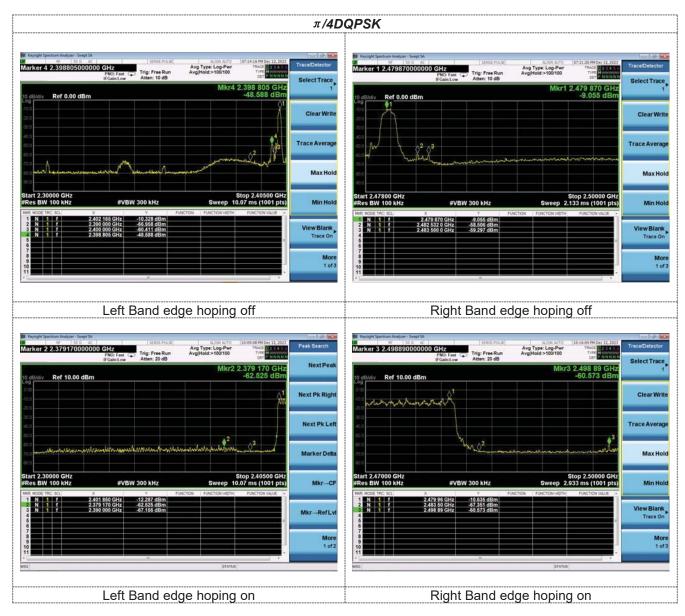




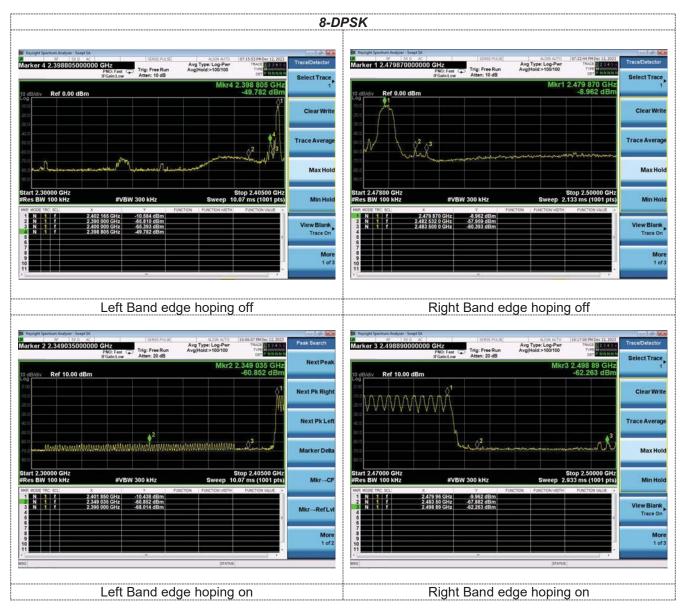
Band-edge Measurements for RF Conducted Emissions:











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4.9 Pseudorandom Frequency Hopping Sequence TEST APPLICABLE

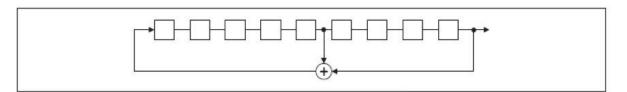
For 47 CFR Part 15C section 15.247 (a) (1) requirement:

Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hop-ping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400–2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW. The system shall hop to channel frequencies that are selected at the system hopping rate from a pseudo randomly ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hop-ping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

EUT Pseudorandom Frequency Hopping Sequence Requirement

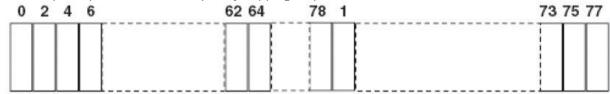
The pseudorandom frequency hopping sequence may be generated in a nice-stage shift register whose 5th and 9th stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first one of 9 consecutive ones, for example: the shift register is initialized with nine ones.

- Number of shift register stages:9
- Length of pseudo-random sequence:29-1=511 bits
- Longest sequence of zeros:8(non-inverted signal)



Linear Feedback Shift Register for Generation of the PRBS sequence

An example of pseudorandom frequency hopping sequence as follows:



Each frequency used equally one the average by each transmitter.

The system receiver have input bandwidths that match the hopping channel bandwidths of their corresponding transmitter and shift frequencies in synchronization with the transmitted signals.



4.10 Antenna Requirement

Standard Applicable

For intentional device, according to FCC 47 CFR Section 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. And according to FCC 47 CFR Section 15.247 (c), if transmitting antennas of directional gain greater than 6dBi are used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6dBi.

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Refer to statement below for compliance

The manufacturer may design the unit so that the user can replace a broken antenna, but the use of a standard antenna jack or electrical connector is prohibited. Further, this requirement does not apply to intentional radiators that must be professionally installed.

Antenna Connected Construction

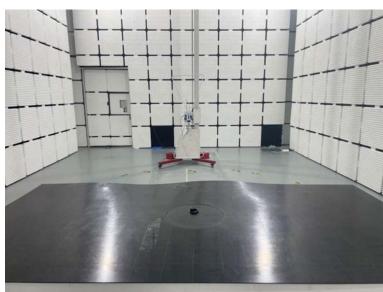
The maximum gain of antenna was 1.7 dBi.

Remark: The antenna gain is provided by the customer, if the data provided by the customer is not accurate, BSL Testing Co., Ltd. does not assume any responsibility.



5 Test Setup Photos of the EUT









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6 Photos of the EUT

Reference to the report ANNEX A of external photos and ANNEX B of internal photos.
